

LIST OF ART CITED BY APPLICANT

(PTO-1449)

10541572 - GAU: 2624

ATTY. DOCKET NO.
SEKI-0011APPLN. SERIAL NO.
10/541,572APPLICANT(S)
Kenichi UEDAINTL. FILING DATE
2/17/2004
U.S. NATL. PHASE FILING
DATE:
2/7/2005~~GROUP 3151~~

U.S. PATENT DOCUMENTS

EXAMINER'S INITIALS	*PATENT NO.	*ISSUE DATE	*INVENTOR NAME	CLASS	SUBCLASS	FILING DATE

U.S. PATENT APPLICATION PUBLICATIONS

	*PATENT APPLN. PUB. NO.	*PUB. DATE	*APPLICANT	CLASS	SUBCLASS	

U.S. PATENT APPLICATIONS

	*APPLN. NO.	*FILING DATE	*INVENTOR	CLASS	SUBCLASS	

FOREIGN PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
/E.M./	CN 1248752A (Appln No. CN 19981020704)	2000-03-29	China (entire document)			Abst ract	

OTHER ART (Including Author, Title, Date, Pertinent Pages, Publisher, Place of Publication, Etc.)

EXAMINER

/Eric Mohr/

DATE CONSIDERED

04/23/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to Applicant.

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ATTY. DOCKET
SEKI-0011

APPL. SERIAL NO.
Natl. Phase of Intl.
Appl. No.
PCT/JP2004/001684

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EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						Yes	No
	JP2003-6567	01-10-03	Japan			X	
	JP 09-251522	09-22-97	Japan	Q		X	
	JP 2001-195536	07-19-01	Japan			X	
	JP 07-036383	02-07-95	Japan			X	
	JP 2000-076411	03-14-00	Japan			X	

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